

<b>Notice of References Cited</b>	Application/Control No. 10/617,603	Applicant(s)/Patent Under Reexamination DAUTELLE, JEAN-MARIE R.	
	Examiner Tanh Q. Nguyen	Art Unit 2182	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0222883 A1	12-2003	Deniau et al.	345/582
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